Outstanding passivation effect by a new mixed-salt interlayer in perovskite solar cells

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Abstract

Non-radiative recombination is a major limit in obtaining efficient metal-halide perovskite photovoltaics. Here, a passivation treatment is developed by applying a mixture of a new ammonium salt, CF₃CF₂CH₂NH₃I (HBAI), and a conventional formamidinium halide, FAX, on top of the 3D perovskite bulk film. The introduction of such an optimized passivation layer effectively suppressed charge recombination by passivating the surface traps of the 3D perovskite film, enabling a well-matched energy alignment at the interface of perovskite/HTM, leading to a high power conversion efficiency (PCE) of over 23% from current (I)-voltage (V) measurements and a stabilized 22.7% PCE, owing to a substantial $V_{OC}$ improvement (above 80 mV in average), coupled with an improved stability.
Metal halide perovskites have attracted significant interests due to their outstanding optoelectronic properties and obtained successive improvements especially in photovoltaics, leading to high power conversion efficiency (PCE) of the perovskite solar cells (PSCs). The first PSC contained a liquid electrolyte, which attained 3.8% of power conversion efficiency (PCE). Nevertheless, immediate attention to PSC was not raised owing to its instability, where the liquid electrolyte readily dissolves the halide perovskite. Subsequently, the development of solid-type PSCs based on a small-molecule hole transport material (HTM) made an important breakthrough in 2012, showing around 10% of PCE with 500 hour-long shelf stability in ambient air. Since then, extensive efforts have been placed on the PSCs and thus achieved significant improvements from the perspective of both performance and fundamental understandings. A state-of-the-art technology of PSCs can afford to reach a remarkable record efficiency of 25.2% in 2020. However, this is still far behind the theoretical limit of 32%, defined by the Shockley-Queisser theory with 1.50 eV of bandgap, which is mainly ascribed to the substantial non-radiative recombination loss in PSCs. In order to hinder the non-radiative recombination in devices, several approaches have been employed such as defect engineering and interface passivation. On one hand, morphological and compositional engineering have been extensively explored to gain an ideally high-quality of defect-less perovskite film. On the other hand, foreign molecules are employed either in the perovskite layer or on top of the perovskite layer, aiming at passivating defects in the perovskite bulk layer or on its surface. It is found that a moderate excess of PbI2 in the perovskite film not only results in favorable bigger perovskite crystallites with higher crystallinity, but also reduces the defect-assisted recombination at the perovskite/TiO2 interface. In addition, a variety of organic molecules have been tried as passivation materials in PSCs. A remarkable PCE of 23.32% was achieved by adopting phenethylammonium iodide (PEAI) as a passivation layer. Its impressive $V_{OC}$ of 1.18 eV corresponds to 94% of the theoretical $V_{OC}$ estimated by the Shockley-Queisser (SQ) limit which indicates the maximum theoretical efficiency obtained from a single p-n junction under the ideal case without non-radiative recombination. Similarly, an ultrahydrophobic 2D passivation layer was obtained from pentafluorophenylethylammonium lead iodide, $(\text{FEA})_2\text{PbI}_4$, on top of the 3D perovskite, demonstrating a PCE over 22% with $V_{OC}$ of 1.10 V. Herein, we develop a highly efficient PSC by designing a new mixed-salt interlayer for the purpose of passivating the 3D perovskite film. While the previous works mostly focused on the passivation effect through organic molecule or 2D perovskite capping layer, this study aims at
achieving not only passivation effect but also efficient energy level alignment by using the benefits of two different salts with internal interaction. The internal interaction between the mixed salts plays an important role which is worth being considered when devising the molecules for passivation. Accordingly, a thin passivation layer is formed by a mixed salts of a novel ammonium salt, CF₃(CF₂)₂CH₂NH₃I (HBAI) and the conventional formamidinium halide (FAX, where X is I, Br, or Cl). The introduction of the optimized passivation layer effectively reduces the surface defects of the 3D perovskite film with efficient charge extraction, showing a PCE of 23.1% from the current (I)-voltage (V) curve and a stabilized 22.7% from the maximum power point (mpp) due to a significant $V_{OC}$ increase, coupled with an improved stability.

A perovskite film composed of Cs₀.₀₅MA₀.₁FA₀.₇₅PbI₂.₉Br₀.₁′⁻⁻₀.₀₅PbI₂, was chosen for the ensured high quality of the film. The perovskite bulk film (photoactive 3D) was prepared by a one-step spin-coating method where chlorobenzene was dripped as an anti-solvent at the end of spinning, followed by 1 hour annealing at 100 °C. An additional passivation layer was deposited on the as-prepared 3D perovskite film after being cooled down to room temperature by spin-coating a solution containing mixed-salts, a novel fluorine-rich ammonium salt of HBAI and FAX (X = I, Br or Cl), which was sequentially post-annealed. A schematic device architecture and the molecular structures of HBAI and FAX are shown in **Figure 1**.

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**Figure 1** Schematic illustration of the device structure (left) and molecular structures of HBAI and FAX (right) used for the passivation layer, where X=I, Br, or Cl.

As shown in **Figure 1**, the mixed passivation layer was employed in the n-i-p architecture of FTO/cp-TiO₂/mp-TiO₂/3D perovskite/passivation layer/spiro-MeOTAD/Au. Remarkably,
more superior photovoltaic performance is observed when HBAI is accompanied with FAX for the passivation layer, compared to the exclusive use of HBAI (see Figure S1). Statistical box charts of the photovoltaic parameters are shown in Figure 2, where the molar ratio between HBAI and FAX was fixed to 1:1. The corresponding average values of Figure 2 are summarized in Table 1. Compared to control devices, the devices employing HBAI·FAX passivation treatment resulted in better performance throughout all the compositions regardless of the halide in FAX, particularly in open circuit voltage ($V_{OC}$) and fill factor (FF), leading to a significant improvement in PCE. The photocurrent density ($J_{SC}$) shows comparable value around 25.2 mA/cm$^2$ and corresponding incident photon-to-current efficiency (IPCE) are shown in Figure S2, where the tendency of integrated $J_{SC}$ is well matched with $J_{SC}$ from I-V curves. However, $V_{OC}$ of 1.06 V from the control device is greatly increased to 1.14 V for HBAI-FAI, 1.15 V for HBAI-FABr and 1.12 V for HBAI-FACl. Furthermore, FF is also notably enhanced by mixed-HBAI-FAX treatment, showing 0.78 for both FAI and FACl and 0.79 for FABr. Accordingly, the mixed-salt of HBAI-FABr leads to the highest average PCE of 22.78%, while the control device demonstrates the average PCE of 20.10%.

Figure 2 Statistical box charts for the photovoltaic parameters of (a) $J_{SC}$, (b) $V_{OC}$, (c) FF and
(d) PCE of devices without a passivation layer (control, black) and with a passivation layer of mixed HBAI·FAX, HBAI·FAI (blue), HBAI·FABr (red), and HBAI·FACl (green). The devices were measured under AM 1.5 G solar irradiance at 100 mW/cm² with a voltage sweep of the reverse scan (RS, from open circuit to short circuit condition).

Table 1 Average photovoltaic parameters of PSCs with and without passivation layers based on different salt compositions, HBAI·FAX.

<table>
<thead>
<tr>
<th>Salt composition for the passivation layer</th>
<th>J_{SC} (mA/cm²)</th>
<th>V_{OC} (V)</th>
<th>FF</th>
<th>PCE (%)</th>
</tr>
</thead>
<tbody>
<tr>
<td>control</td>
<td>25.18</td>
<td>1.06</td>
<td>0.75</td>
<td>20.10</td>
</tr>
<tr>
<td>HBAI·FAI</td>
<td>25.17</td>
<td>1.14</td>
<td>0.78</td>
<td>22.25</td>
</tr>
<tr>
<td>HBAI·FABr</td>
<td>25.26</td>
<td>1.15</td>
<td>0.79</td>
<td>22.78</td>
</tr>
<tr>
<td>HBAI·FACl</td>
<td>25.12</td>
<td>1.12</td>
<td>0.78</td>
<td>21.92</td>
</tr>
</tbody>
</table>

The effect of the HBAI\textsubscript{X}·FABr\textsubscript{1-X} mixed-salt on the photovoltaic parameters (Figure S1) was examined with varying the HBAI ratio (X=0, 0.25, 0.50, 0.75 and 1.00), however maintaining the same total molarity. Notably, the device performances are both improved while applying only FAX or HBAI, however, more superior performance is observed with the mixture. While \(J_{SC}\) shows a negligible difference depending on the composition of HBAI\textsubscript{X}·FABr\textsubscript{1-X} (Figure S1(a)), an obvious change is monitored from \(V_{OC}\) and FF. The highest average \(V_{OC}\) is observed from HBAI\textsubscript{0}·FABr\textsubscript{1} and gradually decreases with increasing HBAI ratio in HBAI\textsubscript{X}·FABr\textsubscript{1-X}, where the \(V_{OC}\) from HBAI\textsubscript{1}·FABr\textsubscript{0} is still higher than that of control devices without the passivation layer (Figure S1(b)). On the other hand, FF is mainly governed by HBAI, showing the highest FF by the equivalent contribution of HBAI and FABr (X=0.5) to the mixed salts (Figure S1(c)). Therefore, the highest average PCE is obtained from HBAI\textsubscript{0.5}·FABr\textsubscript{0.5} (Figure S1(d)), which confirms the optimized ratio of 1:1 in Figure 2. In Figure 3(a) the current (I)-voltage (V) curves of the control device and the HBAI·FABr-based device are compared. It is notable that the HBAI·FABr-based device results in a low hysteresis index (HI) of 1.5%, defined as \((\text{PCE}_{\text{reverse}}-\text{PCE}_{\text{forward}})/\text{PCE}_{\text{reverse}}\)\textsuperscript{22} while the control device suffers from a severe hysteresis. A prominent improvement in \(V_{OC}\) and FF is found from the HBAI·FABr-based device, leading to 23.10% of PCE based on 25.11 mA/cm² of \(J_{SC}\), 1.16 V of \(V_{OC}\) and 0.79 of FF from the reverse scan (RS). The stabilized PCE at maximum power point was indeed
measured and reached 22.7% as shown in Figure 3(b). Furthermore, IPCE spectra in Figure 3(c) ensures the efficient light harvesting and charge collection throughout the broad absorbance window of the 3D perovskite. The integrated IPCE is in accordance with the $J_{SC}$ value from the I-V curve.

![Graph](image)

**Figure 3** (a) I-V curves of the control (black) and HBAI-FABr (red) devices. Reverse scan (RS) and forward scan (FS) are indicated as solid symbols and open symbols, respectively. (b) Power output of the device employing a HBAI-FABr passivation layer at maximum power point as a function of time. (c) IPCE and integrated photocurrent density of the device employing a HBAI-FABr passivation layer.

High resolution scanning electron microscope (HR-SEM) was performed to understand the effect of the mixed-salt (HBAI-FABr) on the morphology of the perovskite layer. The surface images of the control perovskite film and the post-treated film with HBAI-FABr are shown in Figures 4(a) and 4(b), respectively. In the control sample, a dense polycrystalline perovskite film is formed with white crystals, indicative of excessive PbI$_2$ presents on the surface and in the grain boundaries.$^{25}$ When the pristine perovskite is treated with HBAI-FABr, the exposed PbI$_2$ on the surface is no longer observed, resulting in an enhanced film quality in homogeneity and uniformity. The removal of the PbI$_2$ would reduce the series resistance which explains the increase of the FF.
The extinct PbI$_2$ by HBAI-FABr was also evidenced by X-ray diffraction (XRD) patterns where the PbI$_2$ peak shown in the control film at 12.6° readily disappears by the post-treatment with HBAI-FABr, implying the reaction between the remaining PbI$_2$ and the mixed-salt (Figure 5). Notably, the surface reaction with PbI$_2$ is dominantly derived by FABr rather than HBAI. The exclusive use of HBAI for the post-treatment remains the PbI$_2$ peak, indicating a difficulty of direct reaction between PbI$_2$ and HBAI as shown in Figure S3. Cross-sectional SEM with elemental mapping by energy dispersive X-ray (EDX) was measured to examine the depth-dependent element distribution (Figure S4). The EDX mapping demonstrates that fluorine, introduced by HBAI, is mainly located on the top of the 3D perovskite film, underlying that HBAI-FABr forms a thin passivation layer on the surface. It is interesting to note that the distribution of Br is more biased toward the upper film, which is attributed to the contribution from the post-treated HBAI-FABr as well as the tendency of Br being prone to accumulate near the upper layer in the mixed-halide perovskite film.33
In XRD results, it is suggested that the reaction with excess PbI₂ mainly undergoes by FABr. Therefore, $^1$H-nuclear magnetic resonance ($^1$H-NMR) measurements of HBAI, FABr and HBAI-FABr mixed-salt were conducted to further understand the role of HBAI in the mixed-salts system from the perspective of the molecular interactions (Figure 6(a), full spectra in Figure S5). Notably, HBAI containing seven F atoms is easy to form hydrogen-bonding with active protons in the amino group in FABr due to the strong electronegativity. In order to classify different proton signals of the mixed-salt, $^1$H-$^1$H COSY spectroscopy was demonstrated, which is an efficient method to determine spin-spin coupling correlations between neighboring protons, as shown in Figure 6(b). According to the cross peaks in the spectra, the signal peak (8.90 ppm) corresponding to the amino groups of FABr splits into three peaks (9.02 ppm, 8.72 ppm, and 8.69 ppm, respectively) in the mixed-salt of HBAI·FABr. Furthermore, a downfield shift of the NH$_3^+$ peak is observed from 8.74 ppm in HBAI to 8.83 ppm in HBAI·FABr. These obvious chemical shifts are attributed to a change in the hydrogen nucleus electron cloud density caused by atomic interaction. The strong H-F hydrogen-bonding can stabilize the movable FA$^+$ cation to form a stable interlayer on top of the 3D perovskite, which would effectively help to reduce the surface defects and suppress the carrier recombination, as discussed later.

Figure 6 (a) $^1$H-NMR spectra of FABr, HBAI and mixed salts of HBAI·FABr (molar ratio = 1:1) in DMSO; (b) $^1$H-$^1$H COSY spectrum of mixed salts of HBAI·FABr (molar ratio = 1:1) in
DMSO.

To analyze the passivation role of HBAI-FABr, we carried Density Functional Theory (DFT) simulations of a 3D MAPbI$_3$ perovskite slab, which fully covered by HBAI-FABr. By applying a procedure previously reported (see Supporting Information for Computational Details), a PbI$_2$-rich perovskite surface was set as a control and added one layer of FABr, where the Br species are bonded to the undercoordinated Pb atoms. We subsequently considered the interaction of an HBAI layer on top of the perovskite-bound FABr layer. The HBAI-FABr interaction is found to take place in this case through the HBAI fluorine atoms and the hydrogen atoms of FABr, as shown in Figure 7.

![Figure 7](image)

**Figure 7.** (a) HBAI-FABr interacting molecules (above) and the PbI$_2$-rich perovskite slab; (b) HBAI-FABr-passivated perovskite interface.

To evaluate the stability of the covering layer, we calculated the passivation energy of FABr ($E_{\text{pass}}$, in Table 2) and the interaction energy ($E_{\text{int}}$) between the FABr and HBAI layers. A passivation process with $E_{\text{pass}} = 1.36$ eV/molec and a remarkable value of $E_{\text{int}}$ (0.96 eV) were calculated, underlying a favorable interaction between FABr and HBAI, in line with the $^1$H-NMR measurements. These values increase to 1.83 and 1.32 eV when including dispersion interactions through Grimme’s D3 approach. These results confirm the possibility of the HBAI-FABr interaction at the perovskite interface and confirm the spontaneous tendency to
form a passivating film. To fully characterize the energetics of the passivation process, we also calculated the $E_{\text{pass}}$ of HBAI, HBABr, MAI and FAI, (Table 2). FAI shows a similar $E_{\text{pass}}$ with respect to FABr, whereas HBAI and HBABr have a higher passivation energy, indicating that also these salts are expected to interact with the undercoordinated Pb atoms of the surface and to play a role in the passivation process of the surface traps. Moreover, this important interaction provided by HBAI can be associated to a better device stability. Furthermore, the effect of passivating layers on the electronic properties of the composite systems was analyzed. As shown in the density of state reported in Figure S6, by adding the passivation layer, the trap states associated to the undercoordinated Pb on the surface are completely removed, in line with the increasing of $V_{\text{OC}}$. As previously reported, the percentage of passivating molecular coverage can drastically affect the ionization potential and up-shifts the VB to a more positive value. Moreover, the MAI excess up-shifts the VB of the perovskite, leading to an unfavorable mismatch of the energy level with respect to HTM with regards to the hole extraction process. To evaluate the role of HBAI·FABr treatment in determining the VB perovskite shift, we thus calculated the ionization potential of the passivated perovskite, shown in Table 2. The ionization potential of the HBAI·FABr-terminated system shows a slightly more positive ionization potential (4.9 eV) with respect to that obtained for complete MAI passivation (4.7 eV). Moreover, the direct passivation of HBAI leads to a higher ionization potential (5.2 eV). This result is very interesting because of the full passivation with HBAI·FABr layer and with HBAI, which leads to a slight VB down-shift with respect to MAI passivation, ensures at the same time an efficient hole extraction process and a reduction of surface traps.

Table 2 Ionization potentials (eV) for the investigated species and passivation energy.

<table>
<thead>
<tr>
<th>Termination</th>
<th>Ionization potential (IE) (eV)</th>
<th>Passivation energy per molecule (eV)</th>
<th>Passivation energy per molecule (eV) - D3 Interaction</th>
</tr>
</thead>
<tbody>
<tr>
<td>MAI</td>
<td>4.7</td>
<td>1.64</td>
<td></td>
</tr>
<tr>
<td>FAI</td>
<td>4.8</td>
<td>1.36</td>
<td></td>
</tr>
<tr>
<td>FABr</td>
<td>4.9</td>
<td>1.36</td>
<td>1.83</td>
</tr>
<tr>
<td>HBAI</td>
<td>5.2</td>
<td>1.61</td>
<td>2.19</td>
</tr>
<tr>
<td>HBABr</td>
<td>5.3</td>
<td>1.57</td>
<td></td>
</tr>
<tr>
<td>HBAI on FABr*</td>
<td>4.9</td>
<td>0.96</td>
<td>1.32</td>
</tr>
<tr>
<td>PbI$_2$</td>
<td>6.4</td>
<td>-</td>
<td></td>
</tr>
</tbody>
</table>

*This is not a passivation energy but the interaction energy ($E_{\text{int}}$) between FABr-terminated slab and one HBAI monolayer through H⋯F hydrogen bond.
To confirm the proposed passivation effect by the mixed-salts system, further characterization on charge recombination and related trap density was carried out. The control and the post-treated perovskite films were prepared on glass substrates for photoluminescence (PL) measurements to investigate the effect of HBAI·FABr-based passivation layer on the charge recombination behavior. In Figure 8(a), TR-PL spectra are shown and fitted with a second order exponential decay curve where the longer time constant is responsible for radiative charge recombination. The time constant of the 3D perovskite film is increased by 25% from 1.33 µs to 1.66 µs due to the HBAI·FABr-based passivation layer, coming along with increased PL signal in the films. In Figure 8(b), steady-state PL and electroluminescence (EL) spectra are shown, which have been measured on complete devices. Whereas the spectra do not change with passivation, the luminescence intensities increase. Remarkably, the EL intensity (left axis) increases by a factor of 10, which is consistent with the increase of $V_{OC}$ (for the devices under investigation here ca. 60 mV), whereas the PL is only slightly enhanced (right axis). This is a strong evidence that the post-treatment with HBAI·FABr mainly acts on reducing the surface recombination. The overall improved luminescence by the post-treatment with HBAI·FABr indicates the pronounced radiative recombination by suppressing the trap-assisted non-radiative recombination in the presence of the passivation layer. The dark I-V was measured to calculate the trap-filled limit voltage ($V_{TFL}$) and thus estimate the trap density ($N_t$) to assure the passivation effect by the mixed salts of HBAI·FABr (Figure S7). A control device shows 0.67 V of $V_{TFL}$, which is decreased to 0.53 V by employing the passivation layer. $N_t$ is estimated by the following equation,

$$V_{TFL} = \frac{eN_t d^2}{2\varepsilon_0\varepsilon}$$

where $e$ is the elementary charge, $d$ is the perovskite film thickness, $\varepsilon_0$ is the vacuum permittivity, and $\varepsilon$ is the relative dielectric constant. It is found that the surface passivation by HBAI·FABr leads to a decrease in $N_t$ from 1.84·10^{16} cm^{-3} to 1.46·10^{16} cm^{-3}, which is in the reasonable range for perovskite. This suggests the formation of an effective passivation layer by the preferential reaction between FABr and the excessive PbI$_2$, respectively from the HBAI·FABr mixed-salts and the 3D perovskite, which is followed by the internal interaction as confirmed by $^1$H-NMR.
Figure 8 (a) TR-PL of perovskite film with (red) and without (black) a passivation layer of HBAI-FABr. Thick blue and red lines indicate the fitted results with and without the passivation layer, respectively. (b) Luminescence spectra of complete devices. The intensity is given referred to the peak maximum of the control device for EL (left axis, black lines) and PL (right axis, blue lines).

The stability of the devices was monitored in ambient air without any encapsulation for 500 h to see the effect of passivation layer on long-term stability. As shown in Figure 9, control device exhibits overall good long-term stability, showing a 10% loss in PCE mostly due to the apparent reduction in FF, while $J_{SC}$ and $V_{OC}$ are comparably stable for 500 h. Remarkably, the device with the HBAI-FABr-based passivation layer results in an outstanding stability even showing a 2% increase in PCE after 500 h due to the slightly enhanced FF, which is completely opposite to the control device without the passivation layer. The stable FF observed from the HBAI-FABr device is likely to originate from the strong hydrogen-bonding of the mixed salts composing the passivation layer. Similarly, the HBAI-FABr device demonstrated higher operational stability compared to the control device at mpp under full sun intensity in N$_2$ condition. While PCE of the control device dropped by 10% for 450 h, the HBAI-FABr-based device retains 95% of the initial PCE (Figure S8). Furthermore, the enhanced moisture resistance by multiple F atoms on HBAI is evidenced by increased contact angle of water droplet on the perovskite surface from 49.8° for control film to 66.8° for HBAI-FABr-treated film (Figure S9).
In conclusion, a new ammonium salt, HBAI, is adopted coupled with FABr in a mixed-salt form to compose a passivation layer on top of the 3D perovskite bulk film. The use of mixed-HBAI-FABr facilitates the internal interactions between HBAI and FABr through hydrogen bonding, which plays a key role in building the optimized interlayer in terms of defect passivation, energy level alignment, and stability. Devices employing the passivation layer results in outstanding photovoltaic properties, particularly in open-circuit voltage and fill factor compared to control devices without the passivation layer. On one hand, the effect of HBAI-FABr is reflected in the suppressed charge recombination by passivating the surface traps of the 3D perovskite bulk film, as evidenced by the increased PL and EL intensity. Calculated passivation energy by employing the mixed-HBAI-FABr salt is well in accordance with the observed results implying the effectively suppressed non-radiative recombination. On the other hand, the efficient hole extraction is enabled by well-matched energy level with respect to HTM. The employment of the passivation layer is indeed helpful for the long-term
stability by providing more stable interface with reduced defects, leading to an ensured 500 h stability.

**Experimental**

**Synthesis of HBAI**

2,2,3,4,4,4-heptafluorobutan-1-amine (1g, 5.0 mmol) (across, 97%) was dissolved in 30 mL MeOH at 0 °C, hydroiodic acid solution (1 mL) (across, 57% in water) was added dropwise and the solution was stirred for 1 h, then the mixture was removed to room temperature and stirred for another 2 h. After solvent evaporation, the resulted solid residue was washed with diethyl ether three times, affording white solid product(1.40 g, 86% yield). $^1$H NMR (400 MHz, DMSO) $\delta$ 8.74 (s, 3H), 4.02 (t, J = 17.7 Hz, 2H).

**Substrate**

Fluorine doped tin oxide (FTO) substrates (NSG-10) were chemically etched by zinc powder and 4 M HCl solution and sonicated in 2% Hellmanex water solution for 30 min, acetone for 15 min and ethanol for 15 min, respectively. Then, all substrates were further cleaned by UV-Ozone for 15 min. Then, a compact TiO$_2$ layer was deposited on cleaned FTO substrates via spray pyrolysis deposition from a precursor solution of titanium diisopropoxide bis(acetylacetonate) in anhydrous ethanol, with oxygen as carrier gas. Substrates were heated at 450 °C and kept at this temperature for 15 min before and 30 min after the spray of the precursor solution, then left to cool down to room temperature. Mesoporous TiO$_2$ layer was spin-coated at 4000 rpm for 20 s, with the acceleration rate of 2000 rpm/s, using a 30 nm TiO$_2$ paste (Dyesol 30 NR-D) diluted in ethanol with 1:6 volume ratio. After the spin-coating, the substrates were dried at 80 °C for 10 min and then sintered at 450 °C for 30 min under dry air flow.

**Perovskite layer**

The perovskite precursor solution was prepared by dissolving a mixture of cesium iodide (0.07 mmol, TCI Co. Ltd.), methylammonium bromide (0.14 mmol, Dyenamo), formamidinium iodide (1.19 mmol, Dyenamo), lead iodide (1.45 mmol, Alfa Co. Ltd.) in 1 mL mixture of DMF and DMSO (DMF:DMSO=4:1 v/v, Acros). The perovskite solution was spin-coated through two-step program (1000 rpm for 10 s and 6000 rpm for 20 s) with pouring chlorobenzene as an anti-solvent 5s before the end of the second step. Then the substrates were annealed at 100 °C for 1 h in dry air. The mixed passivation layer was spin-coated at 4000 rpm for 20s on the as-prepared perovskite films and dried on a hot plate at 80 °C for 10 min.
Hole transporting layer and Au top contact

The substrates were cooled down to room temperature after annealing the perovskite. A spirofluorene-linked methoxy triphenylamines (spiro-MeOTAD, Merck) solution was deposited by spin coating at 4000 rpm for 20 s, as hole-transporting material. 90 mg spiro-MeOTAD was dissolved in 1 ml chlorobenzene, doped by 20.625 μL bis(trifluoromethylsulfonyl)imide lithium salt solution (520 mg/mL LiTFSI in acetonitrile), and 35.5 μL 4-tert-butylpyridine (tBP, Sigma-Aldrich). Finally, 80 nm of Au top electrode was deposited through thermal evaporator under high vacuum with an active area of 0.16 cm².

Characterization

The solar cell devices were measured using a 300 W Xenon light source (Oriel). The spectral mismatch between AM 1.5 G and the solar simulator was calibrated by a Schott K113 Tempax filter (Prazosopms G;as & Optik GmbH). The light intensity was calibrated with a silicon photodiode with an IR-cutoff filter (KG2, Schott). Current-voltage characteristics were applied by an external voltage bias while measuring the corresponding current with Keithley 2400. The voltage scan rate was 50 mV/s. The devices were covered with a black metal mask with an active area of 0.16 cm². Incident photon to current efficiency (IPCE) was carried by a commercial apparatus (Aekeo-Ariadne, Cicci Research s.r.l.). The top-view and cross-section morphologies of the samples was characterized using a high-resolution scanning electron microscope (Zeiss Merlin) with an in-lens secondary electron detector. The X-ray diffraction patterns were recorded with PANalytical Empyrean system with a PIXcel-1D detector, Bragg-Brentano beam optics and parallel beam optics. Light source is from copper Kα beam filtered with nickel β filter. Diffraction spectra were characterized between 2-theta of 10° and 70° at a scan rate of 1° per minute with the step width of 0.02°. UV-Vis measurements were performed on a Varian Cary 500 spectrometer (Varian USA). Steady-state photoluminescence (PL) and electroluminescence (EL) spectra were obtained with an Andor Kymera 193i spectrometer equipped with a silicon CCD camera (iDus DU240A-OE). Excitation was provided by a CW laser (Obis, 422 nm, 1 mW, beam diameter at 1/e2 0.9±0.1 mm) for PL. For EL, a current of 0.5 mA (ca. 2 mA/cm²) was applied with a Biologic SP-300 potentiostat. Time-resolved photoluminescence (TRPL) was measured by using a picosecond pulse diode laser (EPL-405) with an excitation wavelength of 405 nm, pulse width of 49 ps. ¹H NMR measurements were performed on Bruker AvanceIII-400 MHz NMR spectrometer. Operational stability measurements; SCLC measurements
Conflicts of interest

There are no conflicts to declare.

Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: XXXXX

Statistical box charts depending on the ratio between HBAI and FABr in the mixed-salt; IPCE spectra of the control devices and HBAI-FAI, HBAI-FABr, and HBAI-FACl-treated devices; XRD patterns of the post-treated film with HBAI; cross-sectional SEM image and corresponding EDX mapping; 1H-NMR raw spectra; Isodensity contour plots of DOS layer by layer; I-V response of the electron-only devices employing control perovskite film and the post-treated film with HBAI-FABr; Operational stability; contact angles; computational details.

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References


